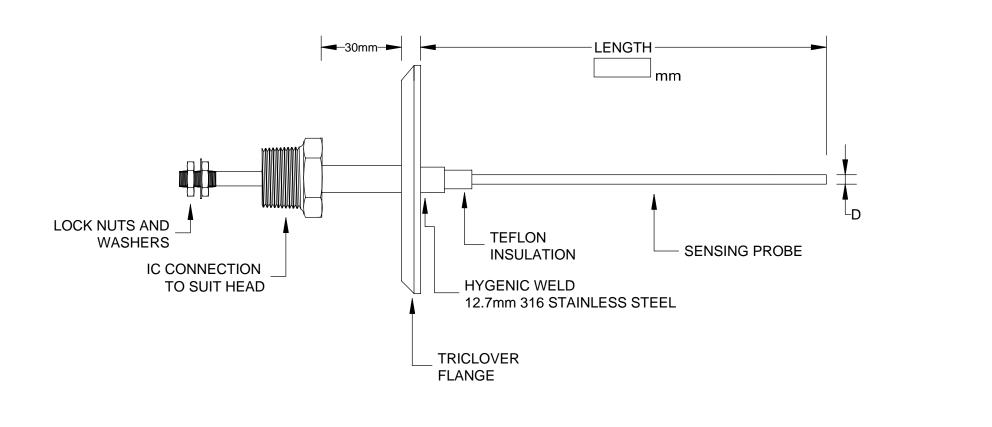
CONDUCTIVITY LEVEL PROBE



PROCESS CAPABILITIES

